

DESCRIPTION

The 50P06D uses advanced trench technology to provide excellent $R_{DS(ON)}$ and low gate charge .This device is suitable for use as a load switch or in PWM applications.



GENERAL FEATURES

$V_{DS} = -60V, I_D = -50A$

$R_{DS(ON)} < 30m\Omega @ V_{GS} = -10V$

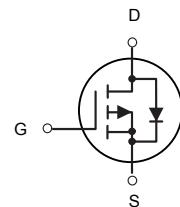
$R_{DS(ON)} < 40m\Omega @ V_{GS} = -4.5V$

High Power and current handing capability

Lead free product is acquired

Surface Mount Package

TO252-2L



P-Channel MOSFET

Application

PWM applications

Load switch

Power management

ABSOLUTE MAXIMUM RATINGS(TA=25°C unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V_{DS}	-60	V
Gate-Source Voltage	V_{GS}	± 20	V
Drain Current-Continuous@ Current-Pulsed (Note 1)	$I_D(25^\circ C)$	-50	A
	$I_D(70^\circ C)$	-20	A
	IDM	-60	A
Maximum Power Dissipation	P_D	60	W
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55 To 175	°C
Thermal Resistance,Junction-to-Ambient (Note 2)	$R_{\theta JA}$	25	°C/W

ELECTRICAL CHARACTERISTICS (TA=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	BVDSS	V _{GS} =0V I _D =-250μA	-60			V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =-48V, V _{GS} =0V			-1	μA
Gate-Body Leakage Current	I _{GSS}	V _{GS} =±20V, V _{DS} =0V			±100	nA
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _D =-250μA	-1	-1.8	-2.5	V
Drain-Source On-State Resistance	R _{Ds(on)}	V _{GS} =-10V, I _D =-20A		22	30	mΩ
		V _{GS} =-4.5V, I _D =-20A		28	40	mΩ
		V _{DS} =-5V, I _D =-20A	5			s
Forward Transconductance	g _{FS}			3060		PF
Input Capacitance	C _{iss}	V _{DS} =-30V, V _{GS} =0V, F=1.0MHz		300		PF
Output Capacitance	C _{oss}			205		PF
Reverse Transfer Capacitance	C _{rss}			14		nS
Turn-on Delay Time	t _{d(on)}	V _{DS} =-30V, V _{GS} =-10V, R _{GEN} =3Ω I _D =1A		20		nS
Turn-on Rise Time	t _r			40		nS
Turn-Off Delay Time	t _{d(off)}			19		nS
Turn-Off Fall Time	t _f			48		nC
Total Gate Charge	Q _g	V _{DS} =-30V, I _D =-20A, V _{GS} =-10V		11		nC
Gate-Source Charge	Q _{gs}			10		nC
Gate-Drain Charge	Q _{gd}			40		nS
Body Diode Reverse Recovery Time	T _{rr}	I _F =-20A, dI/dt=100A/μs		56		nC
Body Diode Reverse Recovery Charge	Q _{rr}			-0.72	-1	V
Diode Forward Voltage (Note 3)	V _{SD}	V _{GS} =0V, I _S =-1A				

NOTES:

1. Repetitive Rating: Pulse width limited by maximum junction temperature.
2. Surface Mounted on 1in² FR4 Board, t ≤ 10 sec.
3. Pulse Test: Pulse Width ≤ 300μs, Duty Cycle ≤ 2%. 4. Guaranteed by design, not subject to production testing.

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

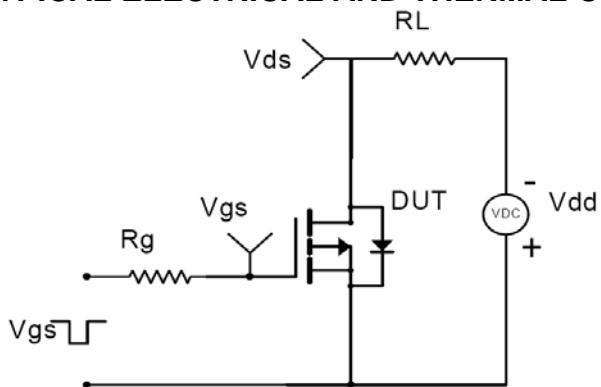


Figure 1:Switching Test Circuit

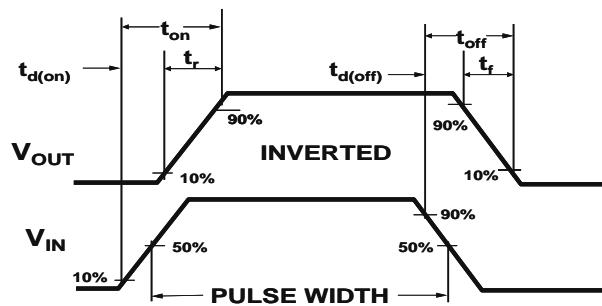


Figure 2:Switching Waveforms

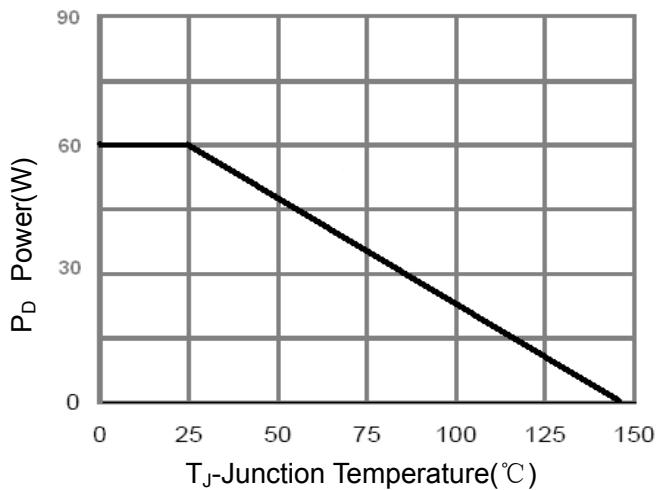


Figure 3 Power Dissipation

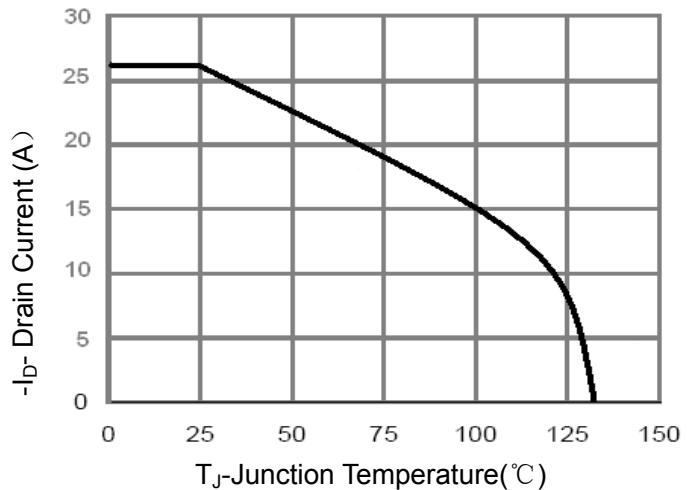


Figure 4 Drain Current

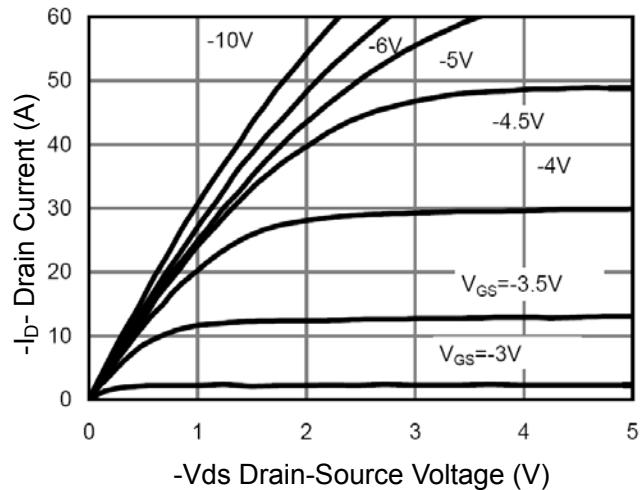


Figure 5 Output CHARACTERISTICS

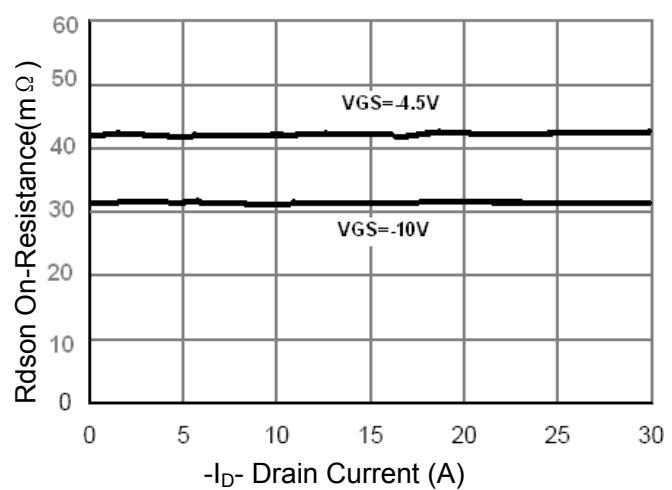
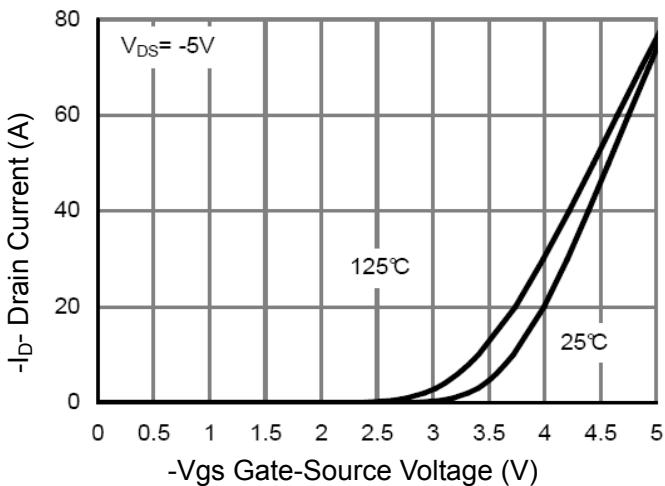
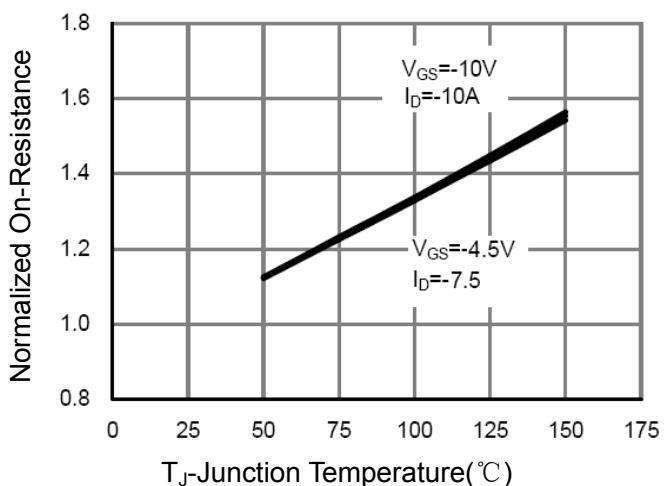
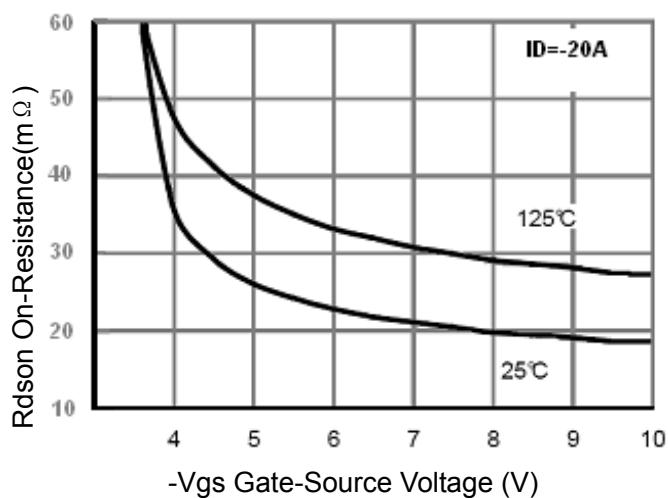
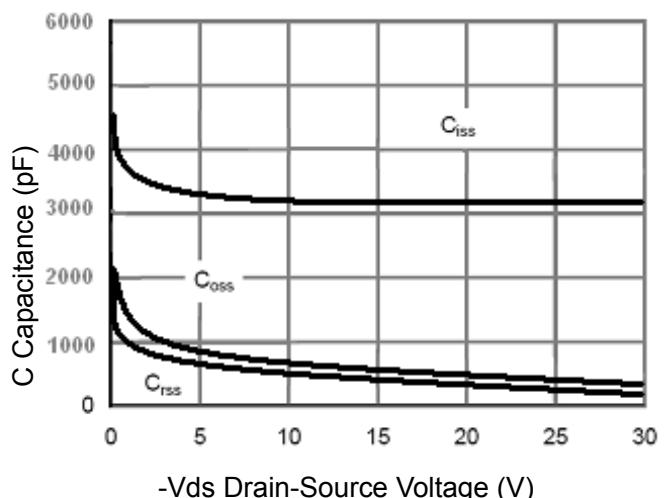
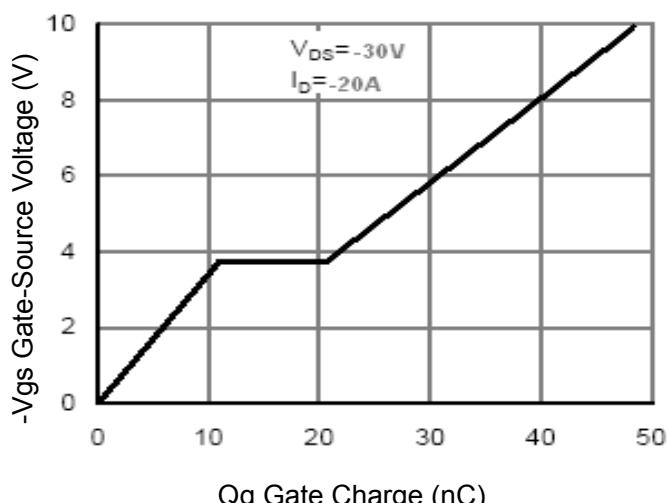
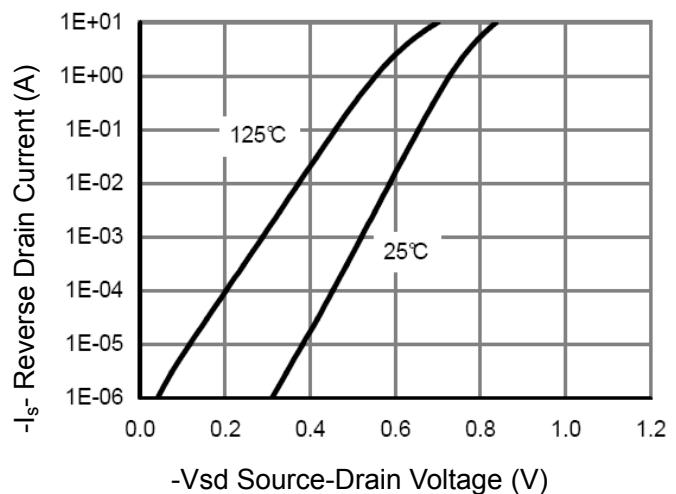


Figure 6 Drain-Source On-Resistance


Figure 7 Transfer Characteristics

Figure 8 Drain-Source On-Resistance

Figure 9 $R_{DS(on)}$ vs V_{GS}

Figure 10 Capacitance vs V_{DS}

Figure 11 Gate Charge

Figure 12 Source- Drain Diode Forward

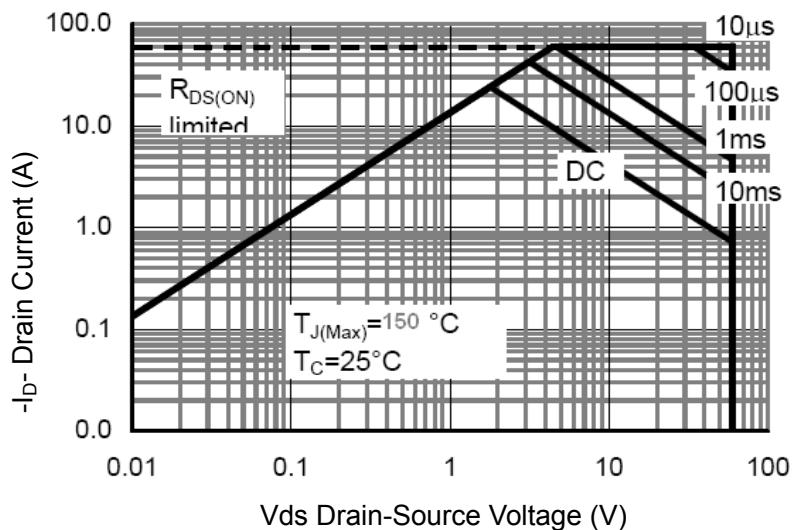


Figure 13 Safe Operation Area

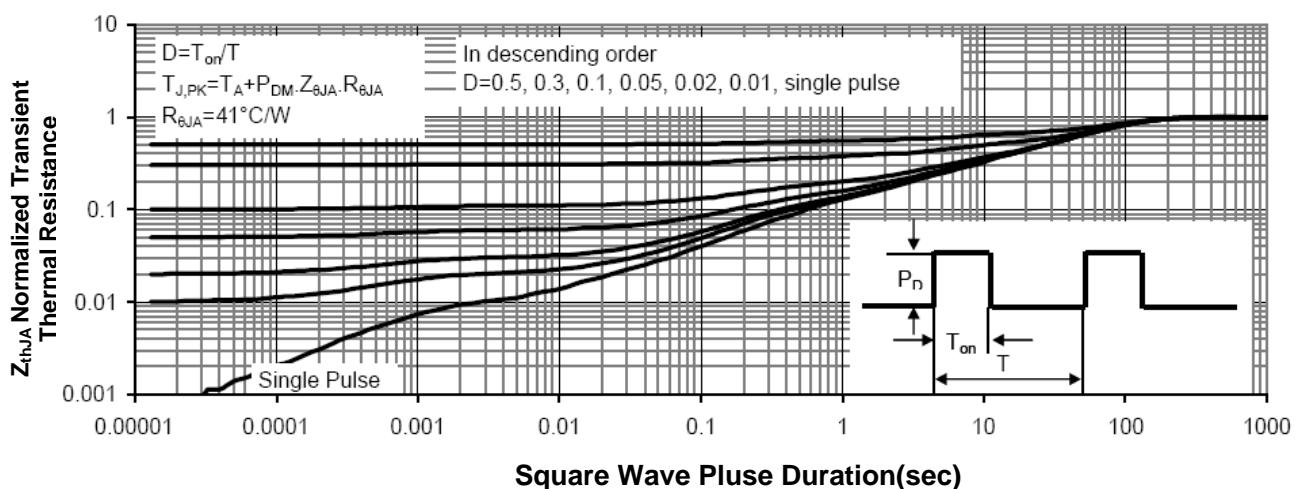
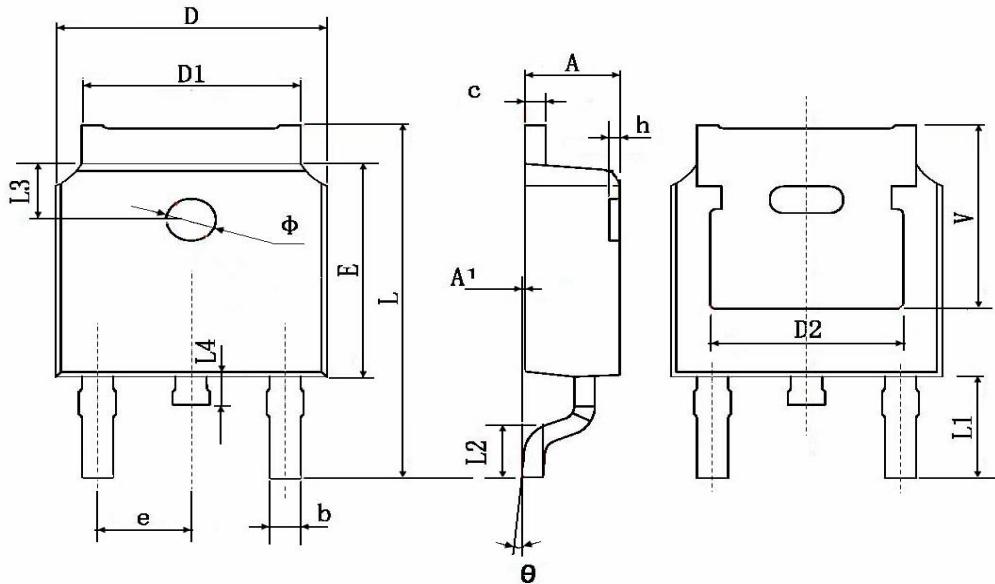


Figure 14 Normalized Maximum Transient Thermal Impedance

TO252-2L Package Information



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	2.200	2.400	0.087	0.094
A1	0.000	0.127	0.000	0.005
b	0.660	0.860	0.026	0.034
c	0.460	0.580	0.018	0.023
D	6.500	6.700	0.256	0.264
D1	5.100	5.460	0.201	0.215
D2	4.830 TYP.		0.190 TYP.	
E	6.000	6.200	0.236	0.244
e	2.186	2.386	0.086	0.094
L	9.800	10.400	0.386	0.409
L1	2.900 TYP.		0.114 TYP.	
L2	1.400	1.700	0.055	0.067
L3	1.600 TYP.		0.063 TYP.	
L4	0.600	1.000	0.024	0.039
Φ	1.100	1.300	0.043	0.051
θ	0°	8°	0°	8°
h	0.000	0.300	0.000	0.012
V	5.350 TYP.		0.211 TYP.	